## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | ORMAZABAL ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2003/0093563	05-2003	Young et al.	709/245
	В	US-20040208186	10-2004	Eichen et al.	370/401
	С	US-2004/0136379	07-2004	Liao et al.	370/395.21
	D	US-2004/0039938	02-2004	Katz et al.	713/201
	Е	US-2003/0115321	06-2003	Edmison et al.	709/224
	F	US-20040244058	12-2004	Carlucci et al.	725/135
	G	US-2003/0135639	07-2003	Marejka et al.	709/232
	H	US-2003/0076780	04-2003	Loge et al.	370/229
	1	US-2002/0083187	06-2002	Sim et al.	709/235
	7	US-6,826,616	11-2004	Larson et al.	709/228
	К	US-5,936,962	08-1999	Haddock et al.	370/446
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s	,				
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	х	*

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